## Applicant(s)/Patent Under Application/Control No. Reexamination 09/888,717 HEIN ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Sam K. Ahn 2637 **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY 375/355 US-6,178,212 B1 01-2001 Akashi, Tamotsu Α Lesea, Austin H. 331/11 US-6,542,040 B1 04-2003 В US-С US-D US-Ε US-F US-G US-Н US-1 US-J US-Κ L US-US-Μ **FOREIGN PATENT DOCUMENTS Document Number** Date Classification Name Country Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

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